Discontinued Product

This version: Mar. 1999

OKI Semiconductor

MSC23CV23218D-xxBS4

2,097,152-word x 32-bit DYNAMIC RAM MODULE : FAST PAGE MODE TYPE

DESCRIPTION

The MSC23CV23218D-xxBS4 is a fully decoded, 2,097,152-word x 32-bit CMOS dynamic random access memory module composed of four 16Mb DRAMs (1Mx16) in TSOP packages mounted with eight decoupling capacitors on a 72-pin glass epoxy small outline package. This module supports any application where high density and large capacity of storage memory are required.

FEATURES

· 2,097,152-word x 32-bit organization
· 72-pin Small Outline Dual In-line Memory module
  MSC23CV23218D-xxBS4 : Gold tab
· Single +3.3V supply ± 0.3V tolerance
· Input : LVTTL compatible
· Output : LVTTL compatible, 3-state
· Refresh : 1024cycles/16ms
· /CAS before /RAS refresh, hidden refresh, /RAS only refresh capability
· Fast page mode capability

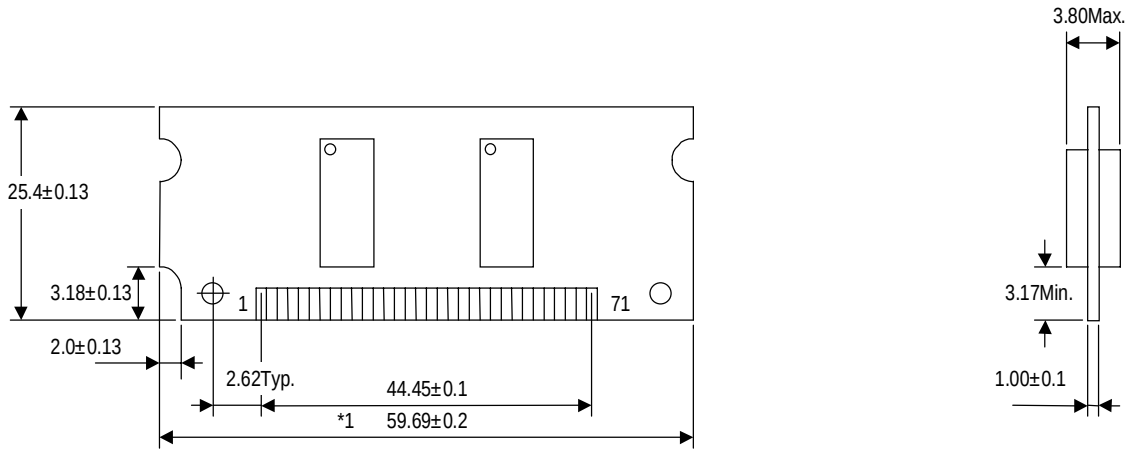
PRODUCT FAMILY

Family	Access Time (Max.)			Cycle Time (Min.)	Power Dissipation	
	t_{RAC}	t_{AA}	t_{CAC}		Operating (Max.)	Standby (Max.)
MSC23CV23218D-60BS4	60ns	30ns	15ns	110ns	864mW	7.2mW
MSC23CV23218D-70BS4	70ns	35ns	20ns	130ns	792mW	

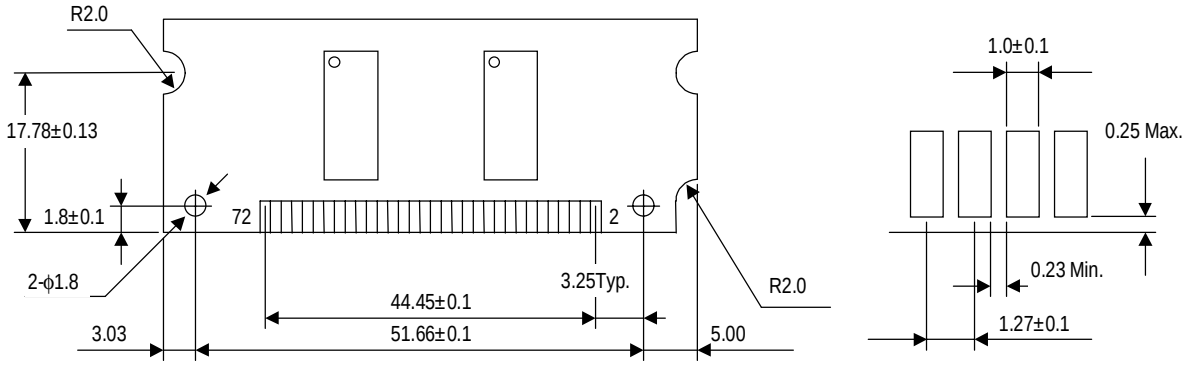
MODULE OUTLINE

MSC23CV23218D-xxBS4

(Unit : mm)



*1 The common size difference of the board width 19.78mm of its height is specified as ±0.2.
The value above 19.78mm is specified as ±0.5.



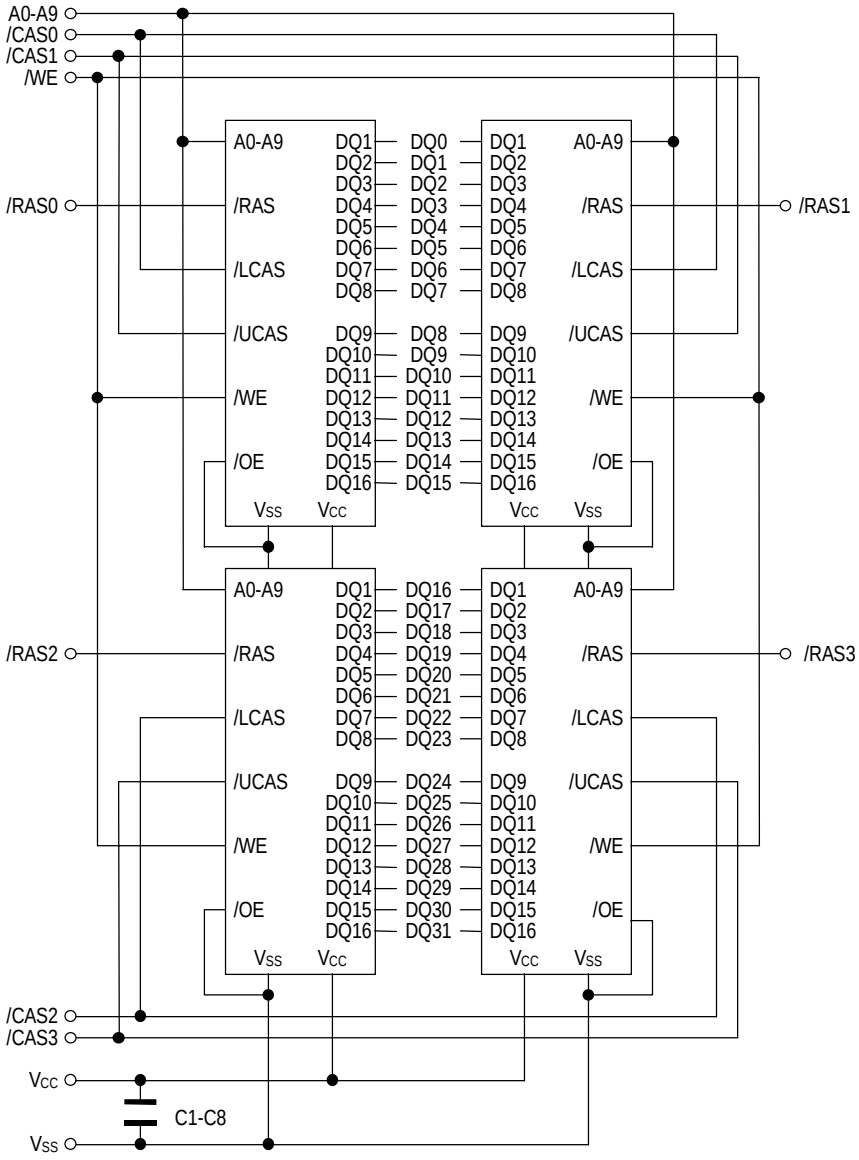
PIN CONFIGURATION

Front Side				Back Side			
Pin No.	**Pin Name**	**Pin No.**	**Pin Name**	**Pin No.**	**Pin Name**	**Pin No.**	**Pin Name**
1	V_{SS}	37	DQ16	2	DQ0	38	DQ17
3	DQ1	39	V_{SS}	4	DQ2	40	/CAS0
5	DQ3	41	/CAS2	6	DQ4	42	/CAS3
7	DQ5	43	/CAS1	8	DQ6	44	/RAS0
9	DQ7	45	/RAS1	10	V_{CC}	46	NC
11	PD1	47	/WE	12	A0	48	NC
13	A1	49	DQ18	14	A2	50	DQ19
15	A3	51	DQ20	16	A4	52	DQ21
17	A5	53	DQ22	18	A6	54	DQ23
19	A10	55	NC	20	NC	56	DQ24
21	DQ8	57	DQ25	22	DQ9	58	DQ26
23	DQ10	59	DQ27	24	DQ11	60	DQ28
25	DQ12	61	V_{CC}	26	DQ13	62	DQ29
27	DQ14	63	DQ30	28	A7	64	DQ31
29	NC	65	NC	30	V_{CC}	66	PD2
31	A8	67	PD3	32	A9	68	PD4
33	/RAS3	69	PD5	34	/RAS2	70	PD6
35	DQ15	71	PD7	36	NC	72	V_{SS}

Presence Detect Pins

Pin No.	Pin Name	-60	-70
11	PD1	NC	NC
66	PD2	V_{SS}	V_{SS}
67	PD3	V_{SS}	V_{SS}
68	PD4	NC	NC
69	PD5	NC	V_{SS}
70	PD6	NC	NC

BLOCK DIAGRAM



ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Voltage on Any Pin Relative to V_{SS}	V_{IN}, V_{OUT}	-0.5 to +4.6	V
Voltage on V_{CC} Supply Relative to V_{SS}	V_{CC}	-0.5 to +4.6	V
Short Circuit Output Current	I_{OS}	50	mA
Power Dissipation	P_D *	4	W
Operating Temperature	T_{OPR}	0 to +70	°C
Storage Temperature	T_{STG}	-40 to +125	°C

* Ta = 25°C

Recommended Operating Conditions

(Ta = 0°C to +70°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit
Power Supply Voltage	V_{CC}	3.0	3.3	3.6	V
	V_{SS}	0	0	0	V
Input High Voltage	V_{IH}	2.0	-	V_{CC}+0.3	V
Input Low Voltage	V_{IL}	-0.3	-	0.8	V

Capacitance

(V_{CC} = 3.3V ± 0.3V, Ta = 25°C, f = 1 MHz)

Parameter	Symbol	Typ.	Max.	Unit
Input Capacitance (A0 - A9)	C_{IN1}	-	31	pF
Input Capacitance (/WE)	C_{IN2}	-	35	pF
Input Capacitance (/RAS0- /RAS3)	C_{IN3}	-	13	pF
Input Capacitance (/CAS0- /CAS3)	C_{IN4}	-	20	pF
I/O Capacitance (DQ0 - DQ31)	C_{DQ}	-	20	pF

DC Characteristics

(V_{CC} = 3.3V ± 0.3V, Ta = 0°C to +70°C)

Parameter	Symbol	Condition	-60		-70		Unit	Note
			Min.	Max.	Min.	Max.		
Input Leakage Current	I_{LI}	0V ≤ V_{IN} ≤ V_{CC}+0.3V; All other pins not under test = 0V	-40	40	-40	40	µA	
Output Leakage Current	I_{LO}	DQ disable 0V ≤ V_{OUT} ≤ V_{CC}	-20	20	-20	20	µA	
Output High Voltage	V_{OH}	I_{OH} = -2.0mA	2.4	V_{CC}	2.4	V_{CC}	V	
Output Low Voltage	V_{OL}	I_{OL} = 2.0mA	0	0.4	0	0.4	V	
Average Power Supply Current (Operating)	I_{CC1}	/RAS, /CAS cycling, t_{RC} = Min.	-	240	-	220	mA	1, 2
Power supply current (Standby)	I_{CC2}	/RAS, /CAS = V_{IH}	-	8	-	8	mA	1
		/RAS, /CAS ≥ V_{CC} -0.2V	-	2	-	2	mA	1
Average Power Supply Current (/RAS only refresh)	I_{CC3}	/RAS cycling, /CAS = V_{IH}, t_{RC} = Min.	-	240	-	220	mA	1, 2
Average Power Supply Current (/CAS before /RAS refresh)	I_{CC6}	/RAS cycling, /CAS before /RAS	-	240	-	220	mA	1, 2
Average Power Supply Current (Fast Page Mode)	I_{CC7}	/RAS = V_{IL}, /CAS cycling, t_{PC} = Min.	-	170	-	160	mA	1, 3

Notes: 1. I_{CC} Max. is specified as I_{CC} for output open condition.
2. The address can be changed once or less while /RAS = V_{IL}.
3. The address can be changed once or less while /CAS = V_{IH}.

AC Characteristics (1/2)

(V_{CC} = 3.3V ± 0.3V, Ta = 0°C to +70°C) Note: 1, 2, 3

Parameter	Symbol	-60		-70		Unit	Note
		Min.	Max.	Min.	Max.		
Random Read or Write Cycle Time	t_{RC}	110	-	130	-	ns	
Fast Page Mode Cycle Time	t_{PC}	40	-	45	-	ns	
Access Time from /RAS	t_{RAC}	-	60	-	70	ns	4, 5, 6
Access Time from /CAS	t_{CAC}	-	15	-	20	ns	4, 5
Access Time from Column Address	t_{AA}	-	30	-	35	ns	4, 6
Access Time from /CAS Precharge	t_{CPA}	-	35	-	40	ns	4
Output Low Impedance Time from /CAS	t_{CLZ}	0	-	0	-	ns	4
/CAS to Data Output Buffer Turn-off Delay Time	t_{OFF}	0	15	0	20	ns	7
Transition Time	t_T	3	50	3	50	ns	3
Refresh Period	t_{REF}	-	16	-	16	ms	
/RAS Precharge Time	t_{RP}	40	-	50	-	ns	
/RAS Pulse Width	t_{RAS}	60	10K	70	10K	ns	
/RAS Pulse Width (Fast Page Mode)	t_{RASP}	60	100K	70	100K	ns	
/RAS Hold Time	t_{RSH}	15	-	20	-	ns	
/CAS Precharge Time (Fast Page Mode)	t_{CP}	10	-	10	-	ns	
/CAS Pulse Width	t_{CAS}	15	10K	20	10K	ns	
/CAS Hold Time	t_{CSH}	60	-	70	-	ns	
/CAS to /RAS Precharge Time	t_{CRP}	5	-	5	-	ns	
/RAS Hold Time from /CAS Precharge	t_{RHCP}	35	-	40	-	ns	
/RAS to /CAS Delay Time	t_{RCD}	20	45	20	50	ns	5
/RAS to Column Address Delay Time	t_{RAD}	15	30	15	35	ns	6
Row Address Set-up Time	t_{ASR}	0	-	0	-	ns	
Row Address Hold Time	t_{RAH}	10	-	10	-	ns	
Column Address Set-up Time	t_{ASC}	0	-	0	-	ns	
Column Address Hold Time	t_{CAH}	10	-	15	-	ns	
Column Address to /RAS Lead Time	t_{RAL}	30	-	35	-	ns	
Read Command Set-up Time	t_{RCS}	0	-	0	-	ns	
Read Command Hold Time	t_{RCH}	0	-	0	-	ns	8
Read Command Hold Time referenced to /RAS	t_{RRH}	0	-	0	-	ns	8

AC Characteristics (2/2)

(V_{CC} = 3.3V ± 0.3V, Ta = 0°C to +70°C) Note: 1, 2, 3

Parameter	Symbol	-60		-70		Unit	Note
		Min.	Max.	Min.	Max.		
Write Command Set-up Time	t_{WCS}	0	-	0	-	ns	
Write Command Hold Time	t_{WCH}	10	-	15	-	ns	
Write Command Pulse Width	t_{WP}	10	-	10	-	ns	
Write Command to /RAS Lead Time	t_{RWL}	15	-	20	-	ns	
Write Command to /CAS Lead Time	t_{CWL}	15	-	20	-	ns	
Data-in Set-up Time	t_{DS}	0	-	0	-	ns	
Data-in Hold Time	t_{DH}	10	-	15	-	ns	
/CAS Active Delay Time from /RAS Precharge	t_{RPC}	5	-	5	-	ns	
/RAS to /CAS Set-up Time (/CAS before /RAS)	t_{CSR}	10	-	10	-	ns	
/RAS to /CAS Hold Time (/CAS before /RAS)	t_{CHR}	10	-	10	-	ns	

Notes: 1. A start-up delay of 200µs is required after power-up, followed by a minimum of eight initialization cycles (/RAS only refresh or /CAS before /RAS refresh) before proper device operation is achieved.

2. The AC characteristics assumes t_T = 5ns.

3. V_{IH}(Min.) and V_{IL}(Max.) are reference levels for measuring input timing signals. Transition time (t_T) are measured between V_{IH} and V_{IL}.

4. This parameter is measured with a load circuit equivalent to 1TTL loads and 100pF.
The output timing reference levels are V_{OH} = 2.0V and V_{OL} = 0.8V.

5. Operation within the t_{RCD}(Max.) limit ensures that t_{RAC}(Max.) can be met.
t_{RCD}(Max.) is specified as a reference point only. If t_{RCD} is greater than the specified t_{RCD}(Max.) limit, then the access time is controlled by t_{CAC}.

6. Operation within the t_{RAD}(Max.) limit ensures that t_{RAC}(Max.) can be met.
t_{RAD}(Max.) is specified as a reference point only. If t_{RAD} is greater than the specified t_{RAD}(Max.) limit, then the access time is controlled by t_{AA}.

7. t_{OFF}(Max.) define the time at which the output achieves the open circuit condition and are not referenced to output voltage levels.

8. t_{RCH} or t_{RRH} must be satisfied for a read cycle.